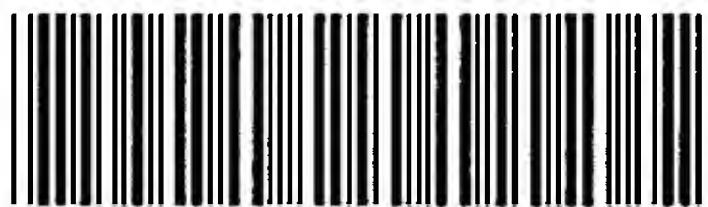


Search Notes**Application/Control No.**

10/605,653

Examiner

Jason M. Han

Applicant(s)/Patent under Reexamination

YU ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	29-30	2/17/2006	JMH
362	97	2/17/2006	JMH
349	61-69	2/17/2006	JMH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	2/17/2006	JMH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner